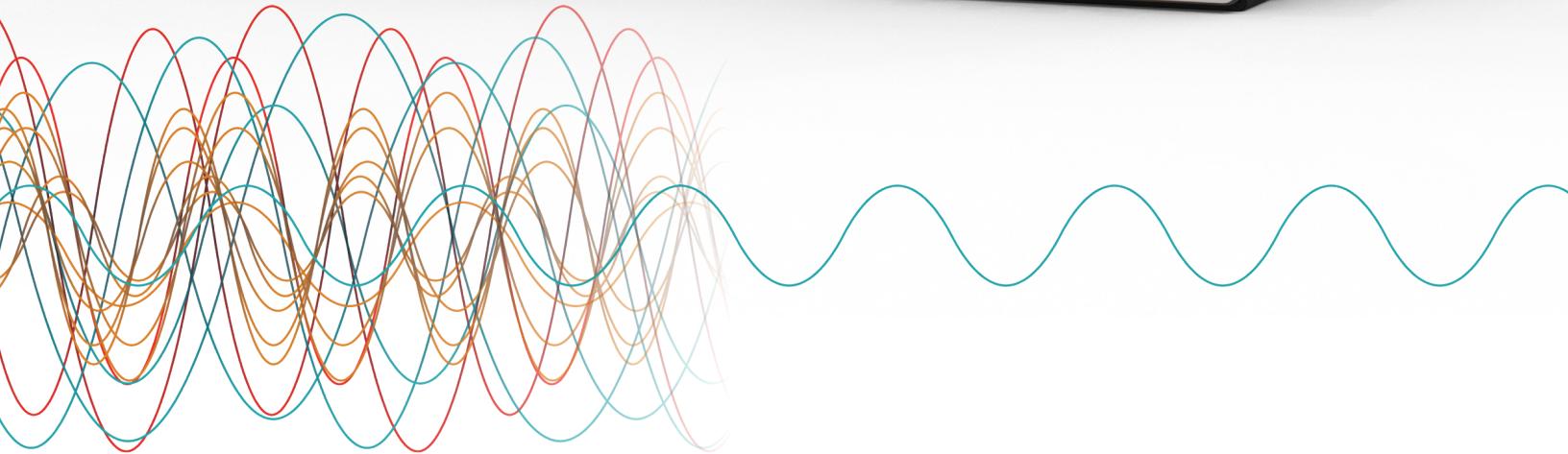


M Measure Ready

**M81
SSM**

SMU-10
Low-noise DC/AC
SMU



First DC/AC SMU with ultra-sensitive lock-in detection

The source measure unit (SMU-10) is the latest module addition to the MeasureReady™ M81-SSM synchronous source measure system. It is specifically designed to handle the delicate nature of nano and ultra-cold samples with exceptionally low source noise and high measurement sensitivity. The SMU-10 offers both DC and AC capabilities and an integrated lock-in, providing a comprehensive suite of measurements tailored to advanced research applications.



The SMU-10 is the latest module addition to the M81-SSM system

Ultra-low
noise

DC & AC
capabilities

Integrated
lock-in

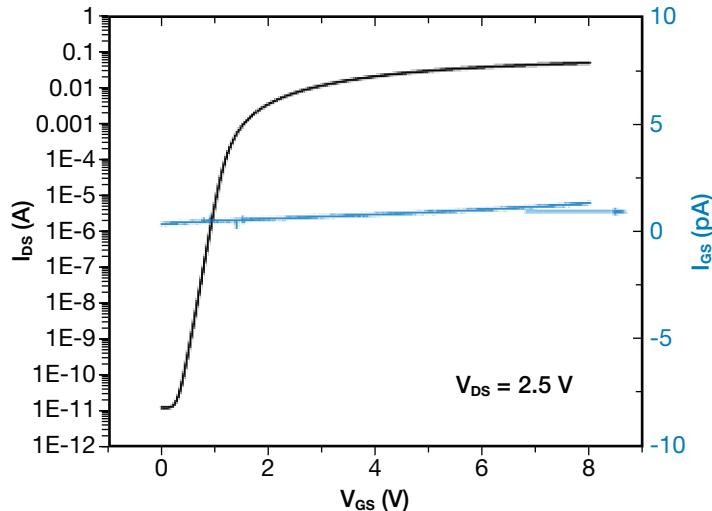
All-in-one precision tool

The SMU-10 integrates 6 instruments into a unified solution

| Measurement | Measure | Source |
|-------------|--|--------------|
| DC current | Down to <100 fA | Up to 100 mA |
| DC voltage | Down to microvolts | Up to 10 V |
| AC current | Sine (up to 100 kHz), triangle (up to 5 kHz), square (up to 5 kHz) | |
| AC voltage | Sine (up to 100 kHz), triangle (up to 5 kHz), square (up to 5 kHz) | |
| Lock-in | Down to nanovolts | N/A |
| Resistance | Milliohms to 100 GΩ | |

Ideal for multi-terminal device testing

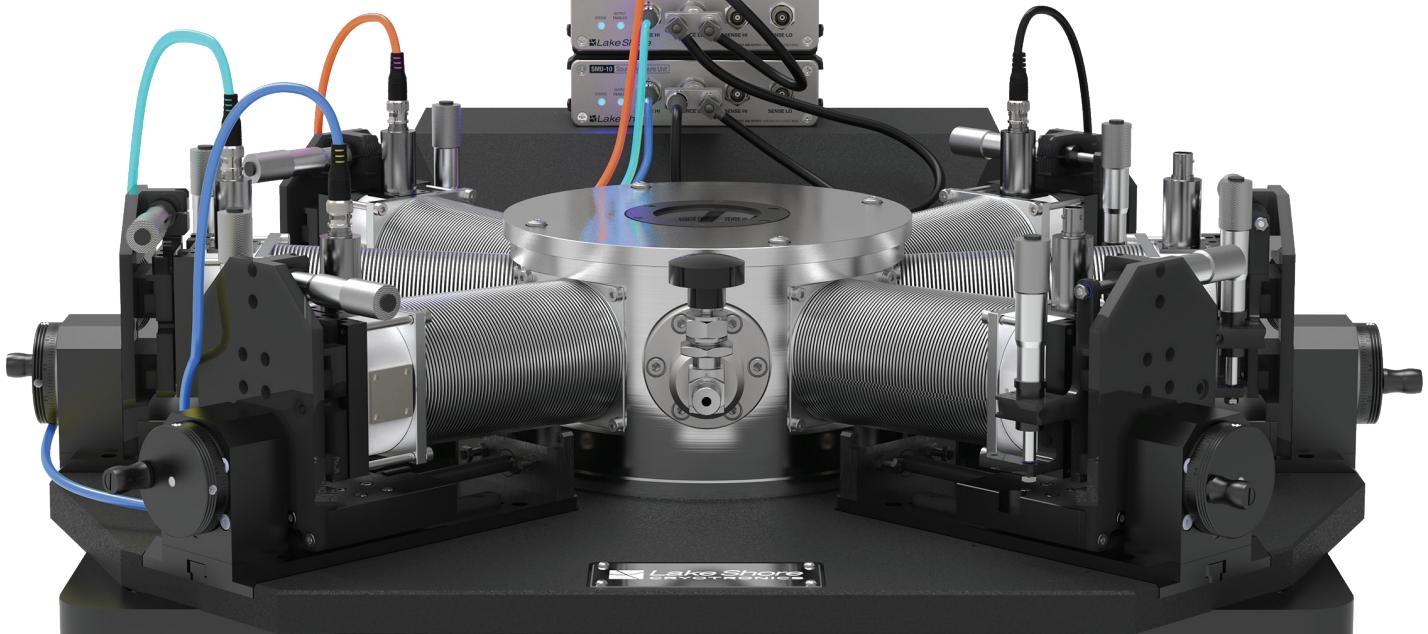
Three-terminal FET DC transfer curve



Source/measure

When testing multi-terminal devices in a cryogenic probe station, use the M81-SSM with SMU-10 modules to apply voltage or current to the DUT and measure the corresponding current or voltage.

The SMU's topology reduces the number of probe arms by half, significantly minimizing thermal impact. Set compliance limits to protect the DUT from accidental overloads.



Advanced resistance

The M81-SSM's advanced resistance mode compensates for phase shifts caused by parasitic capacitance in cryogenic environments, ensuring more accurate resistance measurements. This technique reduces errors significantly, improving measurement accuracy.

Four-wire voltage monitoring

Ideal for high-current devices. The Sense-HI and Sense-LO leads enable 4-wire measurements for built-in device voltage monitoring while sourcing currents.

Synchronized sampling

Patented MeasureSync™ technology ensures perfect timing coordination for AC or DC measurements across multiple SMU-10 modules, eliminating data misalignment errors.

Minimize thermal impact by using SMU-10 modules with a probe station. In this example, the orange wire is the source, the light blue wire is the drain, the dark blue wire is the gate, and the black wire is the ground.

Specifications

| Voltage | Current |
|---|---|
| Ranges: 10 mV, 100 mV, 1 V, 10 V | Ranges: 1 nA, 10 nA, 100 nA, 1 μ A, 10 μ A, 100 μ A, 1 mA, 10 mA, 100 mA |
| Measure sensitivity: <3 nV ¹ | Measure sensitivity: <1 fA ¹ |
| Source noise (DC to 10 MHz): <0.2 mV RMS, <1.2 mV p-p (typical) | DC output resistance: >10 T Ω (typical) Source noise (DC to 10 MHz): <5 nA RMS, <25 nA p-p (typical) |



SMU-10 front view

Ovvervoltage protection: ±200 VDC

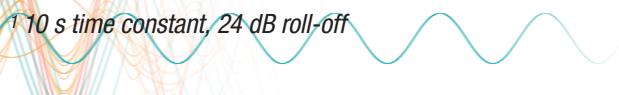
Maximum power: 1 W, 4-quadrant operation

Magnetic field exposure: Operational up to 50 mT DC

Size: 142 mm (5.58 in) W × 38.9 mm (1.53 in) H × 245 mm (9.63 in) L

Noise

| Voltage noise (typical) | Range | Source | | Measure | |
|-------------------------------|-------------|-------------------------------------|--|-------------------------------------|--|
| | | 0.1 Hz to 10 Hz | 1 kHz | 0.1 Hz to 10 Hz | 1 kHz |
| | 10 mV | 250 nV RMS (25 μ V p-p) | 30 nV/ $\sqrt{\text{Hz}}$ | 250 nV RMS (25 μ V p-p) | 30 nV/ $\sqrt{\text{Hz}}$ |
| | 100 mV | 300 nV RMS (2.75 μ V p-p) | 35 nV/ $\sqrt{\text{Hz}}$ | 300 nV RMS (2.75 μ V p-p) | 30 nV/ $\sqrt{\text{Hz}}$ |
| | 1 V | 550 nV RMS (1.5 μ V p-p) | 35 nV/ $\sqrt{\text{Hz}}$ | 550 nV RMS (1.5 μ V p-p) | 40 nV/ $\sqrt{\text{Hz}}$ |
| | 10 V | 5 μ V RMS (1.25 μ V p-p) | 50 nV/ $\sqrt{\text{Hz}}$ | 5 μ V RMS (1.25 μ V p-p) | 180 nV/ $\sqrt{\text{Hz}}$ |
| Current noise (typical) | 1 nA | 100 fA RMS (500 fA p-p) | 6 fA/ $\sqrt{\text{Hz}}$ (at 10 Hz) | 15 fA RMS (75 fA p-p) | 6 fA/ $\sqrt{\text{Hz}}$ (at 10 Hz) |
| | 10 nA | 100 fA RMS (500 fA p-p) | 20 fA/ $\sqrt{\text{Hz}}$ (at 100 Hz) | 45 fA RMS (225 fA p-p) | 20 fA/ $\sqrt{\text{Hz}}$ (at 100 Hz) |
| | 100 nA | 300 fA RMS (1.5 pA p-p) | 60 fA/ $\sqrt{\text{Hz}}$ (at 100 Hz) | 175 fA RMS (875 fA p-p) | 60 fA/ $\sqrt{\text{Hz}}$ (at 100 Hz) |
| | 1 μ A | 1 pA RMS (5 pA p-p) | 200 fA/ $\sqrt{\text{Hz}}$ | 1 pA RMS (5 pA p-p) | 200 fA/ $\sqrt{\text{Hz}}$ |
| | 10 μ A | 5 pA RMS (25 pA p-p) | 1 pA/ $\sqrt{\text{Hz}}$ | 6 pA RMS (30 pA p-p) | 1 pA/ $\sqrt{\text{Hz}}$ |
| | 100 μ A | 50 pA RMS (250 pA p-p) | 3 pA/ $\sqrt{\text{Hz}}$ | 60 pA RMS (300 pA p-p) | 2 pA/ $\sqrt{\text{Hz}}$ |
| | 1 mA | 500 pA RMS (2.5 nA p-p) | 30 pA/ $\sqrt{\text{Hz}}$ | 550 pA RMS (2.75 nA p-p) | 20 pA/ $\sqrt{\text{Hz}}$ |
| | 10 mA | 5 nA RMS (25 nA p-p) | 300 pA/ $\sqrt{\text{Hz}}$ | 5.5 nA RMS (27.5 nA p-p) | 200 pA/ $\sqrt{\text{Hz}}$ |
| | 100 mA | 50 nA RMS (250 nA p-p) | 3 nA/ $\sqrt{\text{Hz}}$ | 55 nA RMS (1.375 μ A p-p) | 2 nA/ $\sqrt{\text{Hz}}$ |



Accuracy

| | Range | Source | | Measure | |
|------------------|-------------|---------------------------------------|--|---------------------------------------|--|
| | | DC ² ± (% rdg + offset) | Lock-in ^{2,3} ± (% rdg + offset) | DC ² ± (% rdg + offset) | Lock-in ^{2,3} ± (% rdg + offset) |
| Voltage accuracy | 10 mV | 0.15% + 300 μ V | 0.15% + 50 nV | 0.15% + 300 μ V | 0.15% + 50 nV |
| | 100 mV | 0.1% + 300 μ V | 0.1% + 500 nV | 0.1% + 300 μ V | 0.1% + 500 nV |
| | 1 V | 0.05% + 600 μ V | 0.05% + 5 μ V | 0.05% + 600 μ V | 0.05% + 5 μ V |
| | 10 V | 0.05% + 2 mV | 0.05% + 50 μ V | 0.05% + 2 mV | 0.05% + 50 μ V |
| | 1 nA | 0.5% + 300 fA | 0.5% + 5 fA | 0.5% + 300 fA | 0.5% + 5 fA |
| | 10 nA | 0.1% + 300 fA | 0.1% + 50 fA | 0.1% + 300 fA | 0.1% + 50 fA |
| Current accuracy | 100 nA | 0.1% + 300 pA | 0.1% + 500 fA | 0.1% + 300 pA | 0.1% + 500 fA |
| | 1 μ A | 0.1% + 300 pA | 0.1% + 5 pA | 0.1% + 300 pA | 0.1% + 5 pA |
| | 10 μ A | 0.05% + 3 nA | 0.05% + 50 pA | 0.05% + 3 nA | 0.05% + 50 pA |
| | 100 μ A | 0.05% + 30 nA | 0.05% + 500 pA | 0.05% + 30 nA | 0.05% + 500 pA |
| | 1 mA | 0.05% + 300 nA | 0.05% + 5 nA | 0.05% + 300 nA | 0.05% + 5 nA |
| | 10 mA | 0.05% + 3 μ A | 0.05% + 50 nA | 0.05% + 3 μ A | 0.05% + 50 nA |
| | 100 mA | 0.05% + 10 μ A | 0.05% + 500 nA | 0.05% + 10 μ A | 0.05% + 500 nA |

Settable resolution

| | Range | Source | |
|-----------------------------|-------------|-------------|---------|
| | | DC | Lock-in |
| Voltage settable resolution | 10 mV | 100 nV | |
| | 100 mV | 1 μ V | |
| | 1 V | 10 μ V | |
| | 10 V | 100 μ V | |
| | 1 nA | 10 fA | |
| | 10 nA | 100 fA | |
| Current settable resolution | 100 nA | 1 pA | |
| | 1 μ A | 10 pA | |
| | 10 μ A | 100 pA | |
| | 100 μ A | 1 nA | |
| | 1 mA | 10 nA | |
| | 10 mA | 100 nA | |
| | 100 mA | 1 μ A | |

² Total system accuracy, 1 year and ± 5 °C from Lake Shore calibration, 24 h and ± 1 °C from self-calibration, 95% confidence

³ DC to 1 kHz or 10% of source range bandwidth, whichever is lower

Temperature coefficient

| | Range | Source ^{2,3} ± (ppm rdg/°C + offset/°C) | Measure ^{2,3} ± (% rdg + offset) |
|--|--------|---|--|
| Voltage temperature coefficient | 10 mV | 25 ppm/°C + 5 µV/°C | 25 ppm/°C + 20 µV/°C |
| | 100 mV | 5 ppm/°C + 5 µV/°C | 10 ppm/°C + 20 µV/°C |
| | 1 V | 5 ppm/°C + 5 µV/°C | 6 ppm/°C + 20 µV/°C |
| | 10 V | 5 ppm/°C + 5 µV/°C | 6 ppm/°C + 100 µV/°C |
| | 1 nA | 5 ppm/°C + 2 pA/°C | 5 ppm/°C + 0.5 pA/°C |
| | 10 nA | 5 ppm/°C + 2 pA/°C | 5 ppm/°C + 0.5 pA/°C |
| | 100 nA | 5 ppm/°C + 2 pA/°C | 5 ppm/°C + 0.5 pA/°C |
| | 1 µA | 5 ppm/°C + 3 pA/°C | 5 ppm/°C + 1.5 pA/°C |
| | 10 µA | 2 ppm/°C + 10 pA/°C | 5 ppm/°C + 1 pA/°C |
| | 100 µA | 2 ppm/°C + 200 pA/°C | 2 ppm/°C + 1 pA/°C |
| Current temperature coefficient ^{1,2} | 1 mA | 2 ppm/°C + 500 pA/°C | 2 ppm/°C + 20 pA/°C |
| | 10 mA | 2 ppm/°C + 10 nA/°C | 2 ppm/°C + 5 nA/°C |
| | 100 mA | 2 ppm/°C + 100 nA/°C | 5 ppm/°C + 10 nA/°C |

Impedance and bandwidth

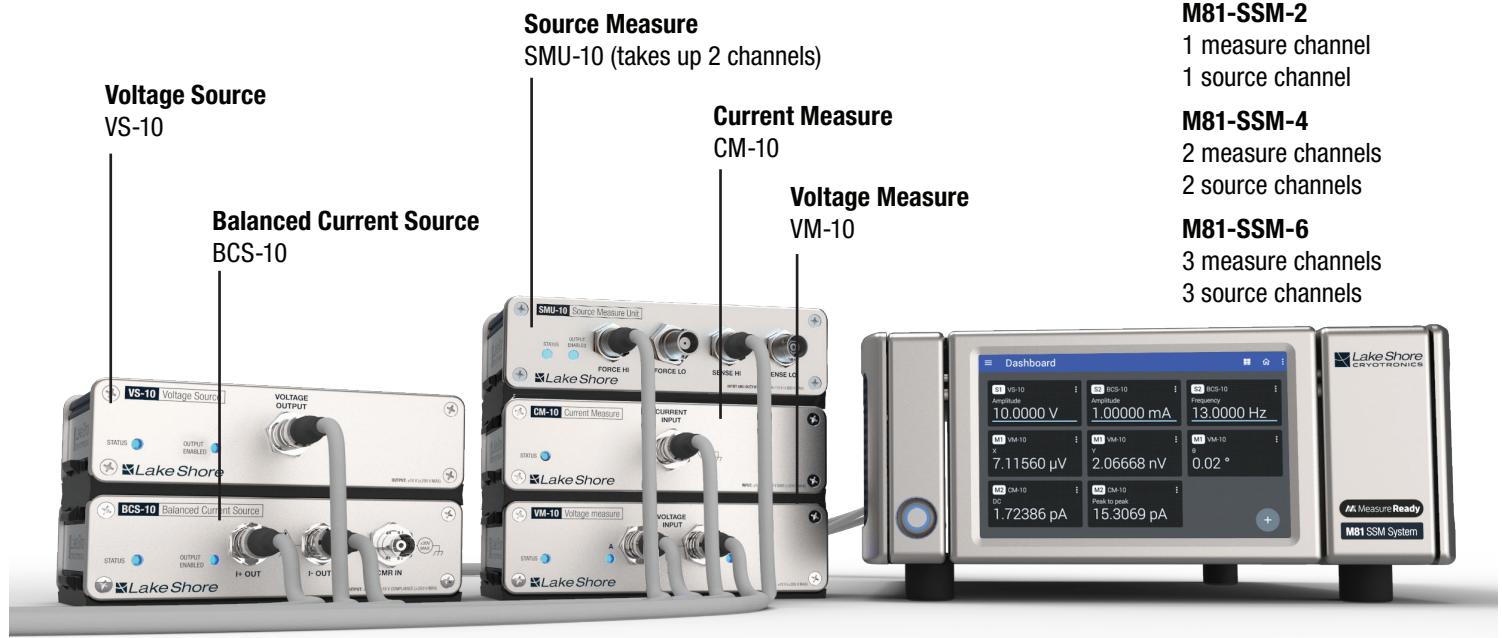
| | Range | Impedance | | Bandwidth (typical) | |
|---------|--------|-----------------|------------------------------------|---------------------|----------|
| | | Output (source) | Input (measure) | Source | Measure |
| Voltage | 10 mV | 0.6 Ω | >100 GΩ (typical, remote sense) | 60 kHz | 60 kHz |
| | 100 mV | | | | |
| | 1 V | | | | |
| | 10 V | | | | |
| | 1 nA | | >10 TΩ | 100 Hz | 350 Hz |
| | 10 nA | | >1 TΩ | 500 Hz | 1.1 kHz |
| | 100 nA | | >100 GΩ | 1 kHz | 2 kHz |
| | 1 µA | | >10 GΩ | 4 kHz | 10 kHz |
| | 10 µA | | >1 GΩ | 10 kHz | 25 kHz |
| | 100 µA | | >100 MΩ | 50 kHz | 65 kHz |
| Current | 1 mA | | >10 MΩ | 100 kHz | >100 kHz |
| | 10 mA | | >1 MΩ | 100 kHz | >100 kHz |
| | 100 mA | | >100 kΩ | 100 kHz | >100 kHz |



M81-SSM system summary

The MeasureReady™ M81-SSM provides a reliable and streamlined approach for advanced measurement applications. Its modular design allows multiple compact modules to connect to the main M81-SSM instrument, enabling a variety of source and measure configurations. Available with two, four, or six channels, the M81-SSM dedicates half of its channels to measure modules and the other half to source modules.

The SMU-10, which occupies two channels (one for sourcing and one for measuring), exemplifies this flexibility. While it can operate on a single source channel, that setup limits its measurement functionality. The M81-SSM simplifies complex instrumentation setups by integrating DC/AC sourcing, DC/AC measuring, resistance measurements, and lock-in capabilities into a single, ultra low-noise solution.



| Available modules | Modes | Range | Ideal for |
|--|--|---------------------------------|--|
| Source measure SMU-10 | DC, sine (up to 100 kHz), triangle (up to 5 kHz), square (up to 5 kHz); current/voltage, lock-in | 10 mV to 10 V 1 nA to 100 mA | Monitoring current while forcing voltage, simplifying wiring, and multi-terminal device measurements |
| Current measure CM-10 | DC, AC, lock-in | 1 nA to 100 mA | Ultra-low noise current measurements |
| Voltage measure VM-10 | DC, AC, lock-in | 10 mV to 10 V | Differential measurements that minimize environmental noise and seamless ranging |
| Voltage source VS-10 | DC, sine (up to 100 kHz), triangle (up to 5 kHz), square (up to 5 kHz) | 10 mV to 10 V | Sourcing small AC signals on large DC offsets with the lowest noise |
| Balanced current source BCS-10 | DC, sine (up to 100 kHz), triangle (up to 5 kHz), square (up to 5 kHz) | 10 nA to 100 mA | Differential measurements that minimize environmental noise |

 Measure Ready

M81 SSM

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